EXAMINER

U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

ATTY. DOCKET NO. IMEC186.001AUS

APPLICATION NO. 09/675,095

CORMATION DISCLOSURE STATEMENT BY APPLICANT

SEVERAL SHEETS IF NECESSARY)

APPLICANT	
Sandini, et	al

FILING DATE September 28, 2000 **GROUP** 2614

U.S. PATENT DOCUMENTS									
EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE (IF APPROPRIATE)			
NV	4,267,573	05/12/81	Chaikin et al.						
VIV	5,166,511	11/27/92	Kreider et al.			-	100 0000		
111/	5,587,580	12/24/96	Venier et al.		L	IECE	IVED		
NV	5,712,729	01/27/98	Hashimoto		Į.	PR 1	8 2001		
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FOREIGN PATENT DOCUMENTS									
EXAMINER INITIAL	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION			
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EXAMINER INITIAL		OTHER DOCU	IMENTS (INCLUDING AUTHOR, TITLE, DATE, PERTINENT F	AGES, ET	C.)				
10	Wodnicki et al.; "A Foveated Imag	je Sensor in Sta	ndard CMOS Technology"; Custom Integrated Circuits Confere	nce, 357-60), 1995.				
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S:\DOCS\BEC	CVREC-5338 DOC/cff/041101								

DATE CONSIDERED

*EXAMINER: INITIAL IF CITATION CONSIDERED, WHETHER OR NOT CITATION IS IN CONFORMANCE WITH MPEP 609; DRAW LINE THROUGH CITATION IF NOT IN CONFORMANCE AND NOT CONSIDERED, INCLUDE COPY OF THIS FORM WITH NEXT COMMUNICATION TO APPLICANT.